

# Seminar #1

This section consists of 2 topics and both are required to be presented during the 1<sup>st</sup> seminar, week 5. Each group (2 or 3 people) should prepare for one presentation.

## Topic 1

Select one power electronic equipment in your daily life and:

- Describe its function, input and output features
- Take a picture and then differentiate as well as mark down:
  - ◆ Power stage
  - ◆ Drive circuit
  - ◆ Control circuit
- Find the model of the power electronic device and component used in this equipment and describe its major parameters

(Such a power electronic equipment could be found in the **Lab of Department of Industrial Automation, 3-4153 room, NO.3 building, iHarbour**. Or you can find one on the Internet.)

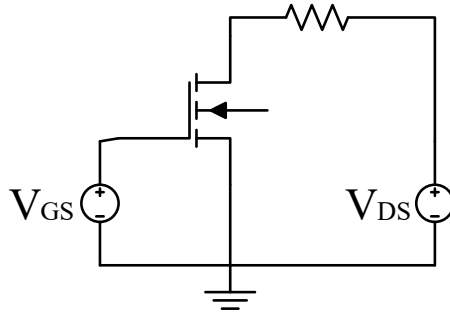
## Topic 2

This topic aims to help you get a basic understanding of power electronic devices through simulation.

Each group will be assigned with a typical fully-controllable power device (MOSFET or IGBT) of certain model. The work to be done includes:

1. Carrying out simulation in LTspice to test the characteristics of the assigned device
2. Comparison between simulation results and the characteristics given by datasheet

The testing circuit for **MOSFET** is shown as below.

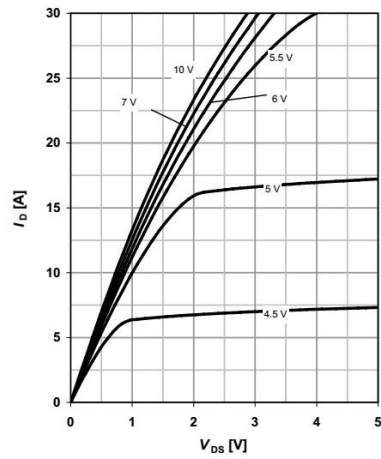


The characteristics required to test includes:

1. Output characteristics (  $I_D = f(V_{DS})$  under different  $V_{GS}$  )

$I_D = f(V_{DS}); T_J = 25^\circ\text{C}$

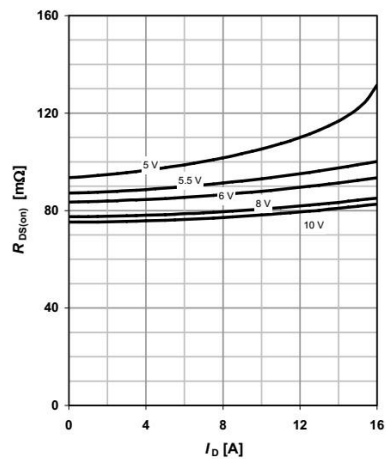
parameter:  $V_{GS}$



2. Drain-source on resistance (  $R_{DS(on)} = f(I_D)$  under different  $V_{GS}$  )

$R_{DS(on)} = f(I_D); T_J = 25^\circ\text{C}$

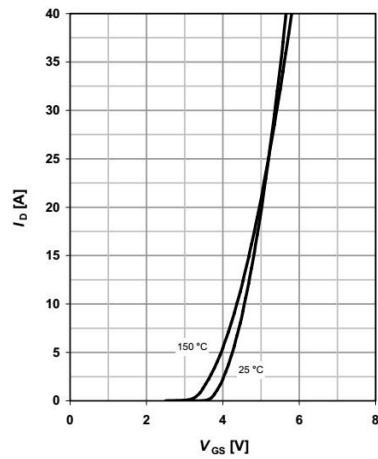
parameter:  $V_{GS}$



3. Transfer characteristics (  $I_D = f(V_{GS})$  with fixed  $V_{DS}$  )

$$I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)max}$$

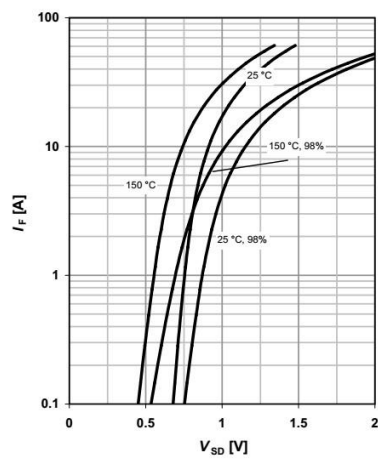
parameter:  $T_j$



#### 4. Forward characteristics of reverse diode ( $I_F = f(V_{SD})$ )

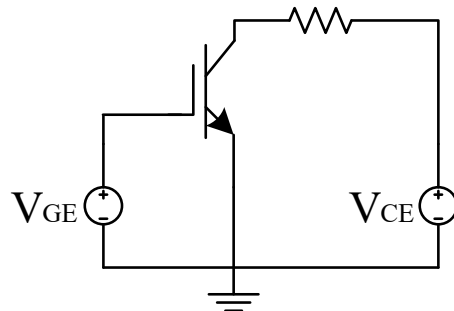
$$I_F = f(V_{SD})$$

parameter:  $T_j$



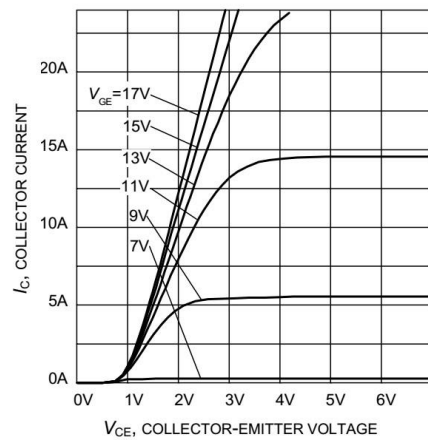
#### 5. Switching waveform (real-time simulation, $V_{GS}$ being pulsating signal)

The testing circuit for **IGBT** is shown as below.

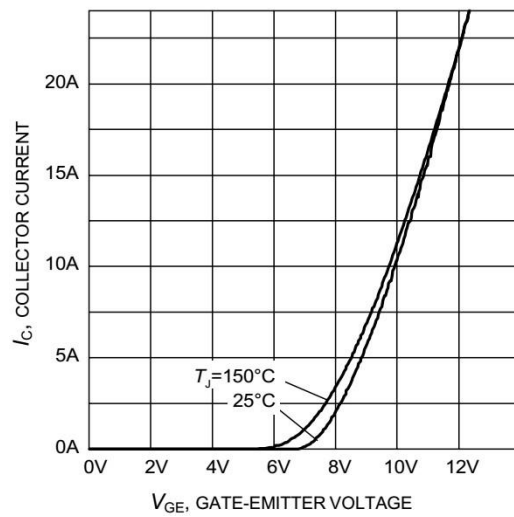


The characteristics required to test includes:

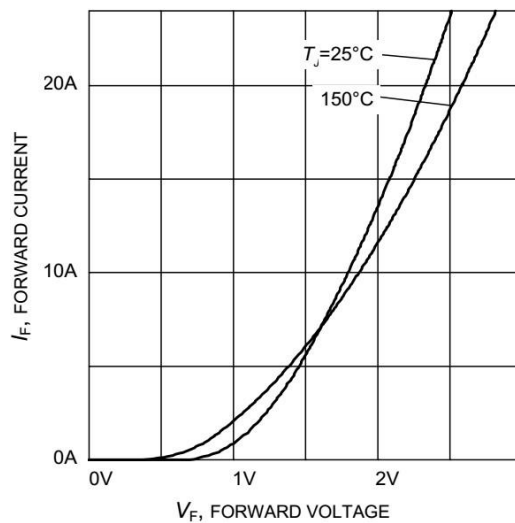
1. Output characteristics (  $I_C = f(V_{CE})$  under different  $V_{GE}$  )



2. Transfer characteristics (  $I_C = f(V_{GE})$  with fixed  $V_{CE}$  )



3. Forward characteristics of reverse diode (  $I_F = f(V_{EC})$  )



4. Switching waveform

(real-time simulation,  $V_{GE}$  being pulsating signal)

The installation file of LTspice as well as corresponding datasheet, tutorial and guide documents are available in **Curriculum Resource**.